

Notice of References Cited	Application/Control No. 10/558,721	Applicant(s)/Patent Under Reexamination DEPPE ET AL.	
	Examiner Tuyet Vo	Art Unit 2821	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,481,163	01-1996	Nakamura et al.	315/308
*	B	US-6,160,361	12-2000	Giannopoulos et al.	315/307
*	C	US-6,163,115	12-2000	Ishizuka, Akio	315/308
*	D	US-6,850,015	02-2005	Ishizuka et al.	315/224
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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